

## Description

These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

## Features

- ◆ 40V,80A, $R_{DS(ON)}=7.5m\Omega$ @ $V_{GS}=10V$
- ◆ Improved dv/dt capability
- ◆ Fast switching
- ◆ 100% EAS Guaranteed
- ◆ Green device available

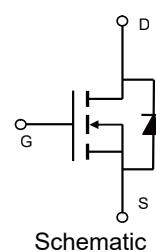
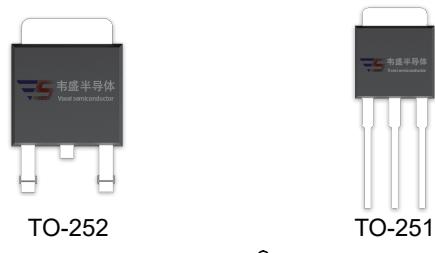
## Applications

- ◆ Motor Drives
- ◆ UPS
- ◆ DC-DC Converter

## Product Summary

|                              |       |
|------------------------------|-------|
| $V_{DSS}$                    | 40V   |
| $R_{DS(on),max}@ V_{GS}=10V$ | 7.5mΩ |
| $I_D$                        | 80A   |

## Pin Configuration



## Absolute Maximum Ratings

 $T_C = 25^\circ C$  unless otherwise noted

| Parameter  | Symbol    | Value       | Unit |
|--|-----------|-------------|------|
| Drain-Source Voltage                             | $V_{DSS}$ | 40          | V    |
| Continuous drain current ( $T_C = 25^\circ C$ )  | $I_D$     | 80          | A    |
| Continuous drain current ( $T_C = 100^\circ C$ ) |           | 52          | A    |
| Pulsed drain current <sup>1)</sup>               | $I_{DM}$  | 320         | A    |
| Gate-Source voltage                              | $V_{GSS}$ | $\pm 20$    | V    |
| Avalanche energy <sup>2)</sup>                   | $E_{AS}$  | 144         | mJ   |
| Power Dissipation ( $T_C = 25^\circ C$ )         | $P_D$     | 83          | W    |
| Storage Temperature Range                        | $T_{STG}$ | -55 to +150 | °C   |
| Operating Junction Temperature Range             | $T_J$     | -55 to +150 | °C   |

## Thermal Characteristics

| Parameter                               | Symbol          | Value | Unit |
|---|-----------------|-------|------|
| Thermal Resistance, Junction-to-Case    | $R_{\theta JC}$ | 1.5   | °C/W |
| Thermal Resistance, Junction-to-Ambient | $R_{\theta JA}$ | 76    | °C/W |

## Package Marking and Ordering Information

| Device      | Device Package | Marking     |
|-------------|----------------|-------------|
| VSM80N04-T2 | TO-252         | VSM80N04-T2 |
| VSM80N04-T1 | TO-251         | VSM80N04-T1 |

## Electrical Characteristics

T<sub>J</sub> = 25°C unless otherwise noted

| Parameter   | Symbol              | Test Condition  | Min. | Typ.  | Max. | Unit |
|---|---------------------|---|------|-------|------|------|
| <b>Static characteristics</b>                                 |                     |   |      |       |      |      |
| Drain-source breakdown voltage                                | BV <sub>DSS</sub>   | V <sub>GS</sub> =0 V, I <sub>D</sub> =250μA                           | 40   | ---   | ---  | V    |
| Gate threshold voltage  | V <sub>GS(th)</sub> | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA              | 1.0  | ---   | 2.0  | V    |
| Drain-source leakage current                                  | I <sub>DSS</sub>    | V <sub>DS</sub> =40 V, V <sub>GS</sub> =0 V, T <sub>J</sub> = 25°C    | ---  | ---   | 1    | μA   |
|   |                     | V <sub>DS</sub> =32 V, V <sub>GS</sub> =0 V, T <sub>J</sub> = 125°C   | ---  | ---   | 10   | μA   |
| Gate leakage current, Forward                                 | I <sub>GSSF</sub>   | V <sub>GS</sub> =20 V, V <sub>DS</sub> =0 V                           | ---  | ---   | 100  | nA   |
| Gate leakage current, Reverse                                 | I <sub>GSSR</sub>   | V <sub>GS</sub> =-20 V, V <sub>DS</sub> =0 V                          | ---  | ---   | -100 | nA   |
| Drain-source on-state resistance                              | R <sub>DS(on)</sub> | V <sub>GS</sub> =10 V, I <sub>D</sub> =20 A                           | ---  | 5.6   | 7.5  | mΩ   |
|   |                     | V <sub>GS</sub> =4.5 V, I <sub>D</sub> =10 A                          | ---  | 7.1   | 9.5  | mΩ   |
| Forward transconductance                                      | g <sub>f</sub>      | V <sub>DS</sub> = 5 V , I <sub>D</sub> =20 A                          | ---  | 63    | ---  | S    |
| <b>Dynamic characteristics</b>                                |                     |   |      |       |      |      |
| Input capacitance   | C <sub>iss</sub>    | V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V,<br>F = 1MHz            | ---  | 2370  | ---  | pF   |
| Output capacitance  | C <sub>oss</sub>    |   | ---  | 316   | ---  |      |
| Reverse transfer capacitance                                  | C <sub>rss</sub>    |   | ---  | 212   | ---  |      |
| Turn-on delay time  | t <sub>d(on)</sub>  | V <sub>DD</sub> = 32V, V <sub>GS</sub> =10V, I <sub>D</sub> =20 A     | ---  | 6.6   | ---  | ns   |
| Rise time   | t <sub>r</sub>      |   | ---  | 110.6 | ---  |      |
| Turn-off delay time   | t <sub>d(off)</sub> |   | ---  | 285.4 | ---  |      |
| Fall time   | t <sub>f</sub>      |   | ---  | 121.1 | ---  |      |
| Gate resistance   | R <sub>g</sub>      | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, F=1MHz                      | ---  | 1.7   | ---  | Ω    |
| <b>Gate charge characteristics</b>                            |                     |   |      |       |      |      |
| Gate to source charge   | Q <sub>gs</sub>     | V <sub>DS</sub> =32 V, I <sub>D</sub> =20A,<br>V <sub>GS</sub> = 10 V | ---  | 9.2   | ---  | nC   |
| Gate to drain charge  | Q <sub>gd</sub>     |   | ---  | 9.6   | ---  |      |
| Gate charge total   | Q <sub>g</sub>      |   | ---  | 51.2  | ---  |      |
| <b>Drain-Source diode characteristics and Maximum Ratings</b> |                     |   |      |       |      |      |
| Continuous Source Current                                     | I <sub>S</sub>      | V <sub>GS</sub> =0V, I <sub>S</sub> =20A, T <sub>J</sub> =25°C        | ---  | ---   | 80   | A    |
| Pulsed Source Current <sup>3)</sup>                           | I <sub>SM</sub>     |   | ---  | ---   | 320  | A    |
| Diode Forward Voltage   | V <sub>SD</sub>     | V <sub>GS</sub> =0V, I <sub>S</sub> =20A, T <sub>J</sub> =25°C        | ---  | ---   | 1.2  | V    |
| Reverse Recovery Time   | t <sub>rr</sub>     | I <sub>s</sub> =20A,di/dt=100A/us, T <sub>J</sub> =25°C               | ---  | 22.4  | ---  | ns   |
| Reverse Recovery Charge                                       | Q <sub>rr</sub>     |   | ---  | 10.5  | ---  | nC   |

### Notes:

1: Repetitive Rating: Pulse width limited by maximum junction temperature.

2: V<sub>DD</sub>=20V, V<sub>GS</sub>=10V, L=0.5mH, I<sub>AS</sub>=24A, R<sub>G</sub>=25Ω, Starting T<sub>J</sub>=25°C.

3: Pulse Test: Pulse Width ≤300 μ s, Duty Cycle≤2%.

## Electrical Characteristics Diagrams

Figure 1. Typ. Output Characteristics

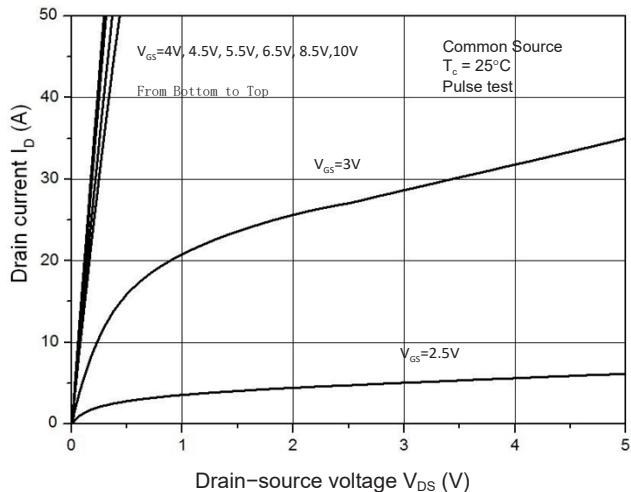


Figure 2. Transfer Characteristics

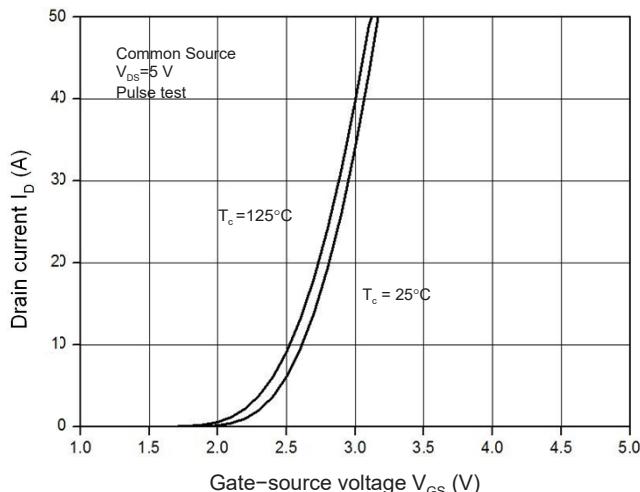


Figure 3. Capacitance Characteristics

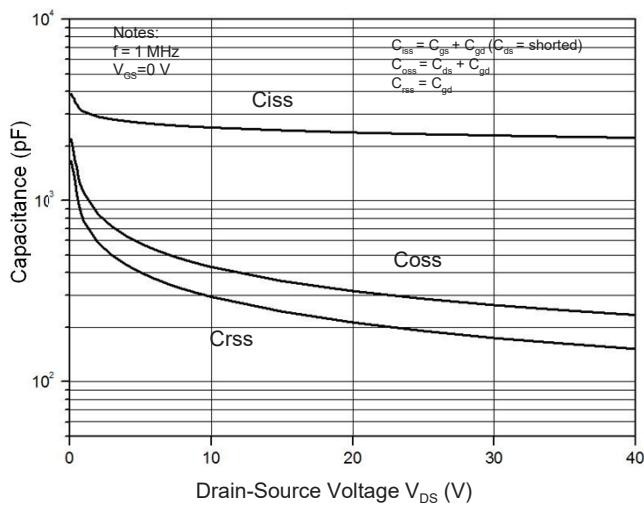


Figure 4. Gate Charge Waveform

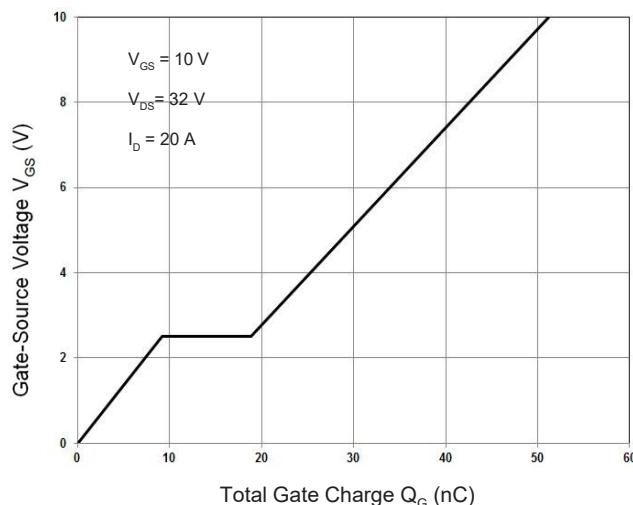


Figure 5. Body-Diode Characteristics

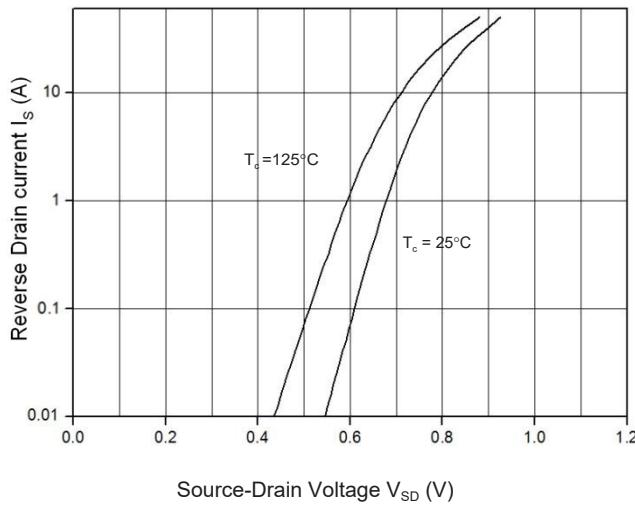


Figure 6. Rdson-Drain Current

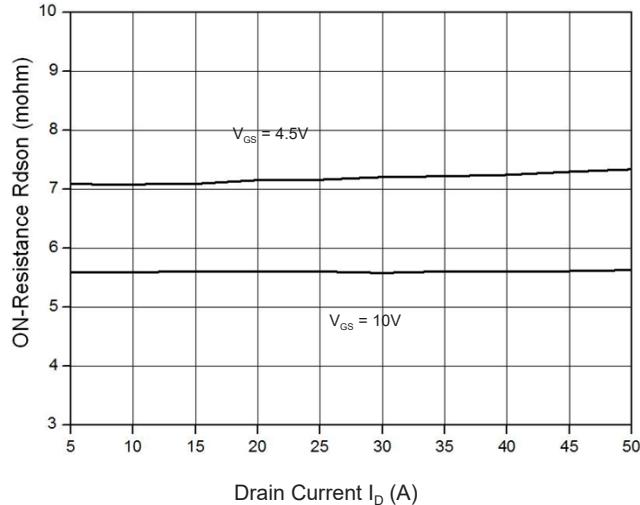


Figure 7. Rdson-Junction Temperature(°C)

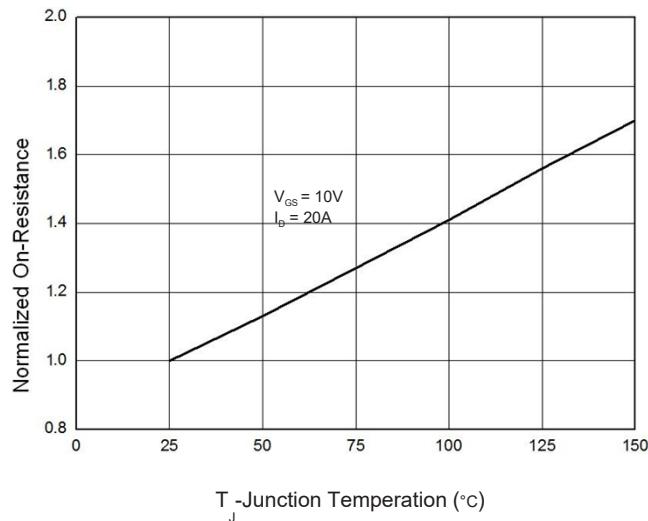


Figure 8. Maximum Safe Operating Area

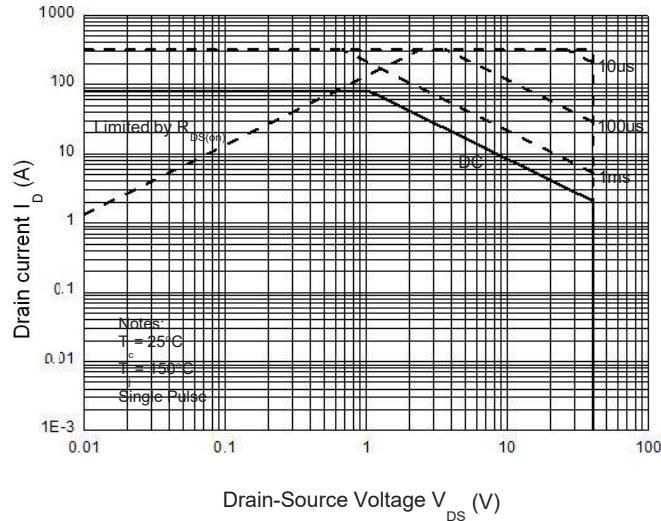
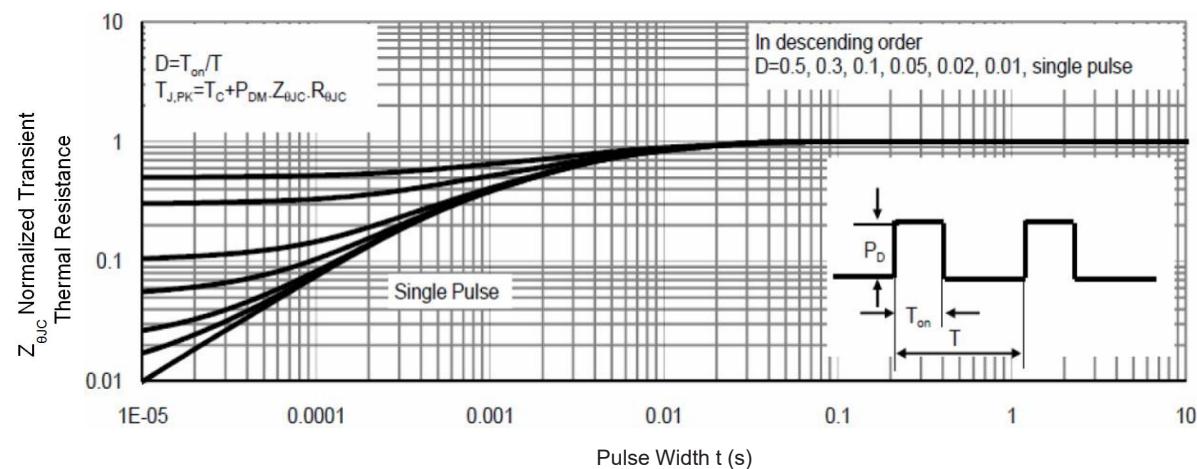


Figure 9. Normalized Maximum Transient Thermal Impedance (RthJC)



## Test Circuit & Waveform

Figure 8. Gate Charge Test Circuit & Waveform

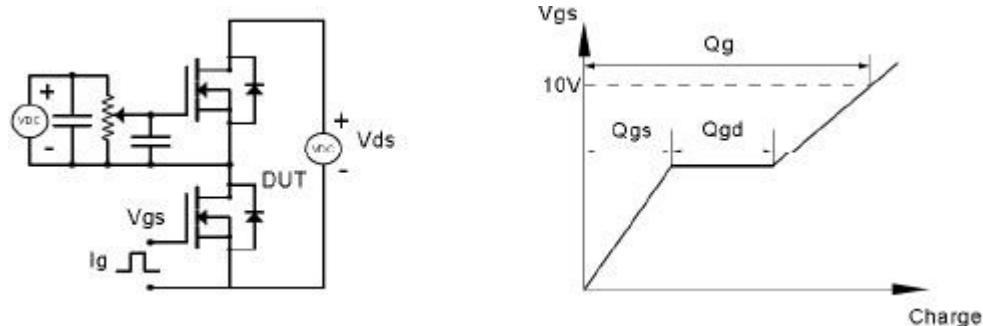


Figure 9. Resistive Switching Test Circuit & Waveforms

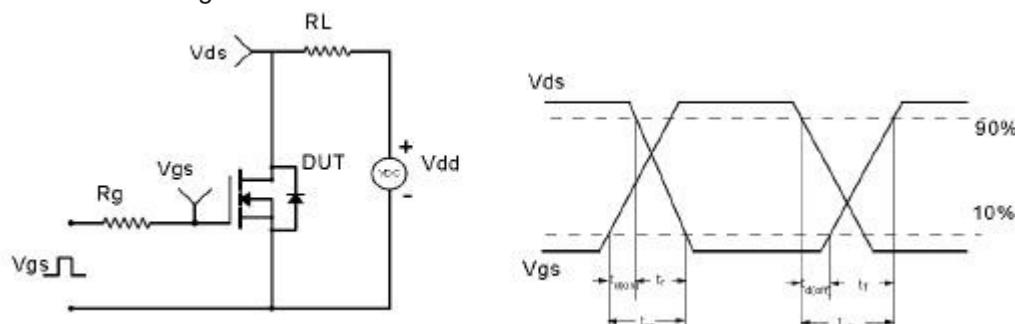


Figure 10. Unclamped Inductive Switching (UIS) Test Circuit & Waveform

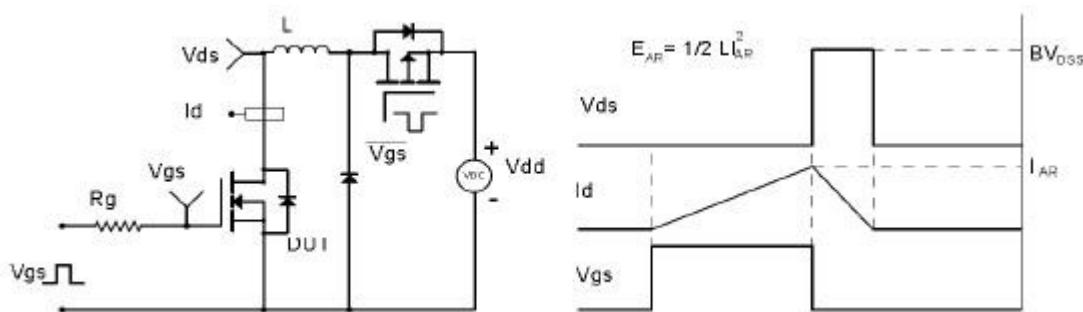


Figure 11. Diode Recovery Circuit & Waveform

